U.S. Departi									
	ment o	f Commerce, Patent	and Trademark	Atty. Docket No.			Application No.		
INFORMATION DISCLOSURE STATEMENT BY				SENS.007US1	SENS.007US1			10/619,731	
		APPLICANT	OIPE 40	Applicant(s)			Conf. No.		
(Use several sheets if necessary)				Wayne Glenn RENKEN			7022		
(Form PTO-1449) OCT OF 1805				Filing Date	Filing Date			Art Group	
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			U.S. P	atent Documents			1		
*Examiner	Document					Filing Date			
Initial	:	Number	Date	Name	Class	Subclass	If Appro	priate	
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	2	5,670,218	09-1997	BAEK					
	3	6,494,955	12-2002	LEI et al.					
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			Foreign	Patent Documents			_		
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N	4	Smith et al., "Mod performance of ch	leling the impact o	f thermal history during I resists", Proceeding of	post exposure	bake on the li		01),	
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